

**SiC**

Silicon Carbide Diode

**5<sup>th</sup> Generation thinQ!<sup>TM</sup>**

650V SiC Schottky Diode

**IDL12G65C5**

**Final Data Sheet**

Rev. 2.0, 2013-12-05

**Power Management & Multimarket**

## 5<sup>th</sup> Generation thinQ!<sup>TM</sup> SiC Schottky Diode

IDL12G65C5

### 1 Description

ThinQ!<sup>TM</sup> Generation 5 represents Infineon leading edge technology for the SiC Schottky Barrier diodes. The Infineon proprietary diffusion soldering process, already introduced with G3 is now combined with a new, more compact design and thin-wafer technology. The result is a new family of products showing improved efficiency over all load conditions, resulting from both the improved thermal characteristics and a lower figure of merit ( $Q_c \times V_f$ ).

The new thinQ!<sup>TM</sup> Generation 5 has been designed to complement our 650V CoolMOS<sup>TM</sup> families: this ensures meeting the most stringent application requirements in this voltage range.

#### Features

- Revolutionary semiconductor material - Silicon Carbide
- Benchmark switching behavior
- No reverse recovery/ No forward recovery
- Temperature independent switching behavior
- High surge current capability
- Pb-free lead plating; RoHS compliant
- Qualified according to JEDEC<sup>1)</sup> for target applications
- Breakdown voltage tested at 27 mA<sup>2)</sup>
- Optimized for high temperature operation

#### Benefits

- System efficiency improvement over Si diodes
- System cost / size savings due to reduced cooling requirements
- Enabling higher frequency / increased power density solutions
- Higher system reliability due to lower operating temperatures
- Reduced EMI

#### Applications

- Switch mode power supply
- Power factor correction
- Solar inverter
- Uninterruptible power supply

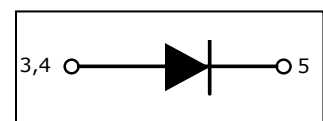
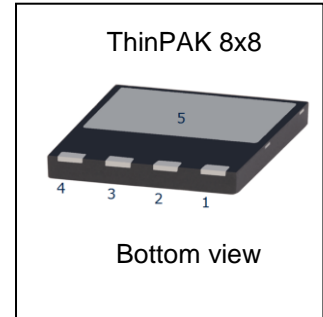
**Table 1 Key Performance Parameters**

| Parameter                 | Value | Unit    |
|---------------------------|-------|---------|
| $V_{DC}$                  | 650   | V       |
| $Q_C; V_R=400V$           | 18    | nC      |
| $E_C; V_R=400V$           | 4.1   | $\mu J$ |
| $I_F @ T_C < 145^\circ C$ | 12    | A       |

**Table 2 Pin Definition**

| Pin 1 | Pin 2 | Pin 3 | Pin 4 | Pin 5 |
|-------|-------|-------|-------|-------|
| n.c.  | n.c.  | A     | A     | C     |

| Type / ordering Code | Package   | Marking |
|----------------------|-----------|---------|
| IDL12G65C5           | PG-VSON-4 | D1265C5 |



#### Related Links

- <http://www.infineon.com/sic>
- [ThinPAK Webpage](#)
- [ThinPAK Application Note](#)

1) J-STD20 and JEDEC22

2) All devices tested under avalanche conditions for a time period of 10ms

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## 2 Maximum ratings

**Table 3** Maximum ratings

| Parameter   | Symbol         | Values |      |      | Unit             | Note/Test Condition                                    |
|---|----------------|--------|------|------|------------------|--|
|   |                | Min.   | Typ. | Max. |                  |  |
| Continuous forward current                          | $I_F$          | –      | –    | 12   | A                | $T_C < 145^\circ\text{C}$ , $D=1$                      |
| Surge non-repetitive forward current, sine halfwave | $I_{F,SM}$     | –      | –    | 57   |                  | $T_C = 25^\circ\text{C}$ , $t_p=10\text{ ms}$          |
|   |                | –      | –    | 50   |                  | $T_C = 150^\circ\text{C}$ , $t_p=10\text{ ms}$         |
| Non-repetitive peak forward current                 | $I_{F,max}$    | –      | –    | 505  |                  | $T_C = 25^\circ\text{C}$ , $t_p=10\text{ }\mu\text{s}$ |
| i <sup>2</sup> t value                              | $\int i^2 dt$  | –      | –    | 16.5 | A <sup>2</sup> s | $T_C = 25^\circ\text{C}$ , $t_p=10\text{ ms}$          |
|   |                | –      | –    | 12.6 |                  | $T_C = 150^\circ\text{C}$ , $t_p=10\text{ ms}$         |
| Repetitive peak reverse voltage                     | $V_{RRM}$      | –      | –    | 650  | V                | $T_j = 25^\circ\text{C}$                               |
| Diode dv/dt ruggedness                              | $dv/dt$        | –      | –    | 100  | V/ns             | $V_R=0..480\text{ V}$                                  |
| Power dissipation                                   | $P_{tot}$      | –      | –    | 138  | W                | $T_C = 25^\circ\text{C}$                               |
| Operating and storage temperature                   | $T_j; T_{stg}$ | -55    | –    | 150  | °C               |  |

## 3 Thermal characteristics

**Table 4** Thermal characteristics

| Parameter                            | Symbol     | Values |      |      | Unit | Note/Test Condition   |
|--------------------------------------|------------|--------|------|------|------|---|
|                                      |            | Min.   | Typ. | Max. |      |   |
| Thermal resistance, junction-case    | $R_{thJC}$ | –      | 0.7  | 0.9  | K/W  | SMD version, device on PCB, 6cm <sup>2</sup> cooling area <sup>1)</sup> |
| Thermal resistance, junction-ambient | $R_{thJA}$ | –      | –    | 45   |      |   |

1) Device on 40mm\*40mm\*1.5mm one layer epoxy PCB FR4 with 6cm<sup>2</sup> copper area (thickness 70μm) for drain connection. PCB is vertical without air stream cooling.

## 4 Electrical characteristics

**Table 5 Static characteristics**

| Parameter             | Symbol   | Values |      |      | Unit          | Note/Test Condition                             |
|-----------------------|----------|--------|------|------|---------------|---|
|                       |          | Min.   | Typ. | Max. |               |   |
| DC blocking voltage   | $V_{DC}$ | 650    | –    | –    | V             | $I_R = 0.19 \text{ mA}, T_j = 25^\circ\text{C}$ |
| Diode forward voltage | $V_F$    | –      | 1.5  | 1.7  |               | $I_F = 12 \text{ A}, T_j = 25^\circ\text{C}$    |
|                       |          | –      | 1.8  | 2.1  |               | $I_F = 12 \text{ A}, T_j = 150^\circ\text{C}$   |
| Reverse current       | $I_R$    | –      | 0.65 | 190  | $\mu\text{A}$ | $V_R = 650 \text{ V}, T_j = 25^\circ\text{C}$   |
|                       |          | –      | 0.16 | 68   |               | $V_R = 600 \text{ V}, T_j = 25^\circ\text{C}$   |
|                       |          | –      | 2.4  | 1350 |               | $V_R = 650 \text{ V}, T_j = 150^\circ\text{C}$  |

**Table 6 AC characteristics**

| Parameter               | Symbol | Values |      |      | Unit | Note/Test Condition  |
|-------------------------|--------|--------|------|------|------|--|
|                         |        | Min.   | Typ. | Max. |      |  |
| Total capacitive charge | $Q_c$  | –      | 18   | –    | nC   | $V_R = 400 \text{ V}, di/dt = 200 \text{ A}/\mu\text{s}, I_F \leq I_{F,MAX}, T_j = 150^\circ\text{C}.$ |
| Total Capacitance       | C      | –      | 360  | –    | pF   | $V_R = 1 \text{ V}, f = 1 \text{ MHz}$   |
|                         |        | –      | 48   | –    |      | $V_R = 300 \text{ V}, f = 1 \text{ MHz}$   |
|                         |        | –      | 47   | –    |      | $V_R = 600 \text{ V}, f = 1 \text{ MHz}$   |

## 5 Electrical characteristics diagrams

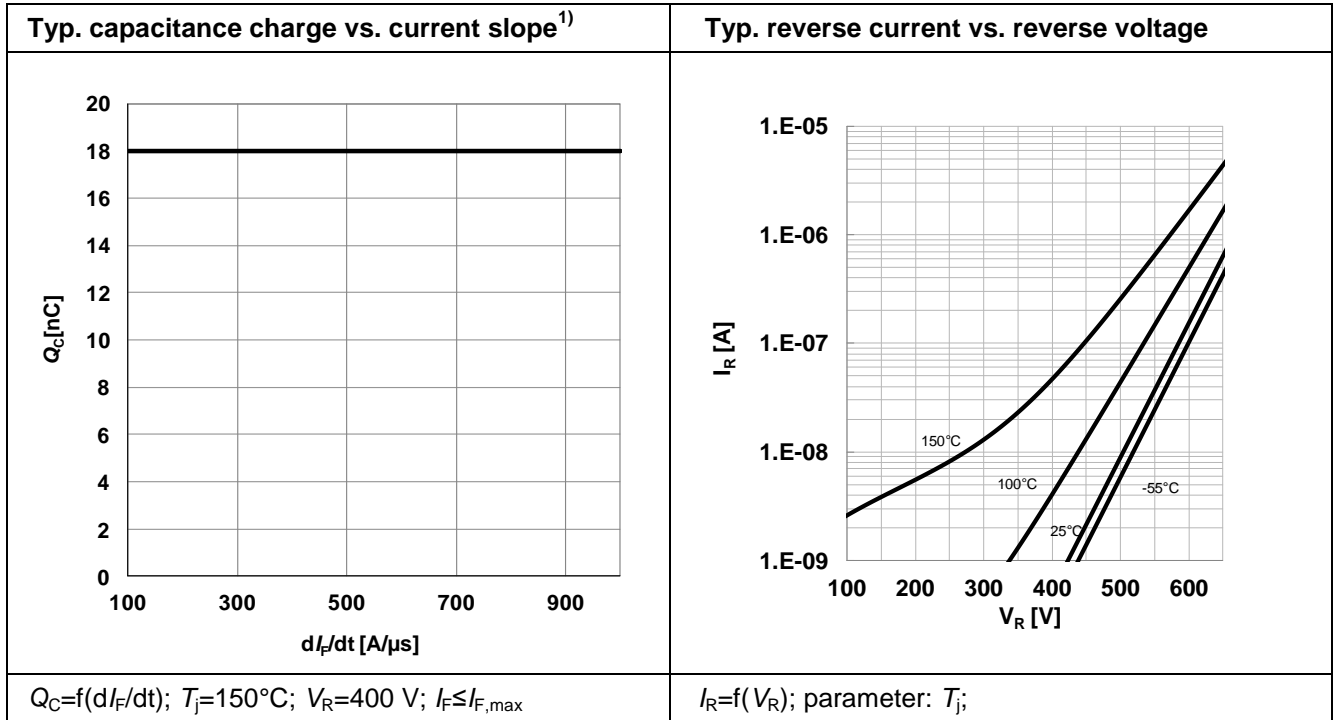
Table 7

| Power dissipation              | Maximal diode forward current   |
|--------------------------------|---|
|                                |   |
| $P_{tot}=f(T_c); R_{thJC,max}$ | $I_F=f(T_c); R_{thJC,max}; T_j \leq 150^\circ\text{C}; \text{parameter } D=\text{duty cycle}$ |

Table 8

| Typical forward characteristics                           | Typical forward characteristics in surge current          |
|---|---|
|   |   |
| $I_F=f(V_F); t_p=200 \mu\text{s}; \text{parameter: } T_j$ | $I_F=f(V_F); t_p=200 \mu\text{s}; \text{parameter: } T_j$ |

Table 9



1) Only capacitive charge, guaranteed by design.

Table 10

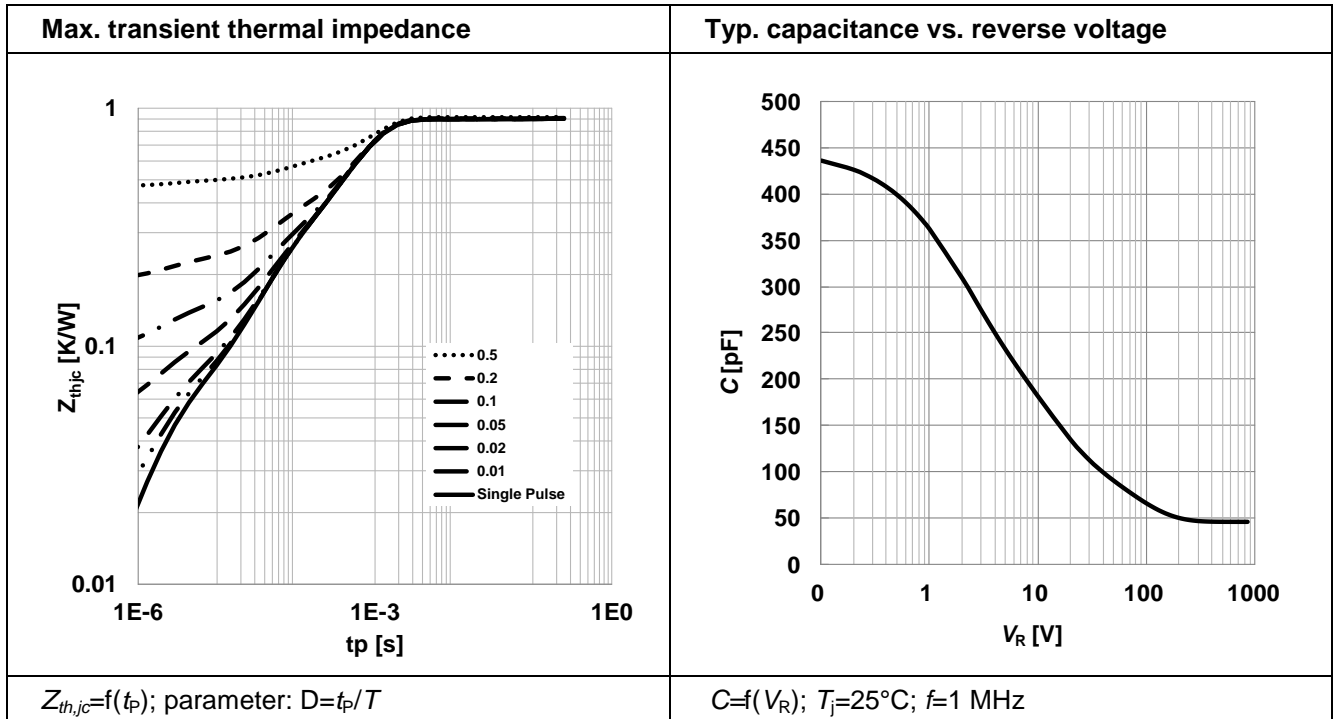
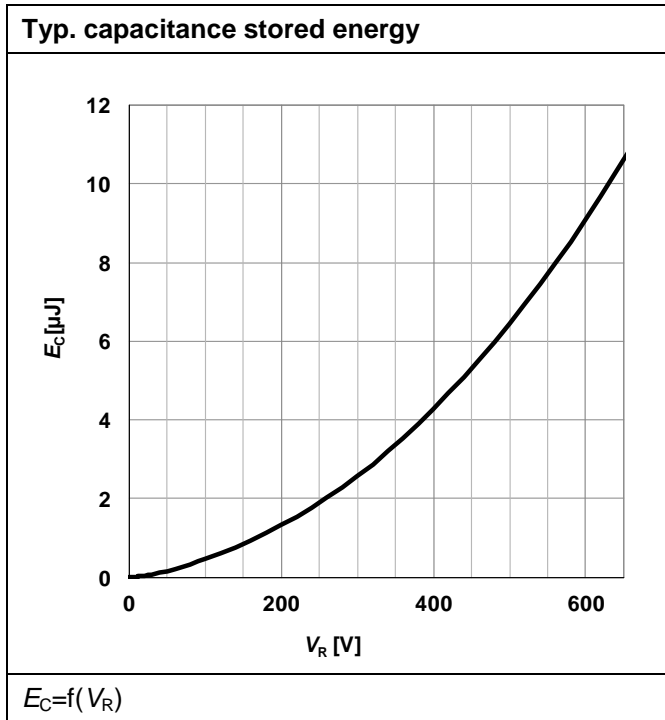
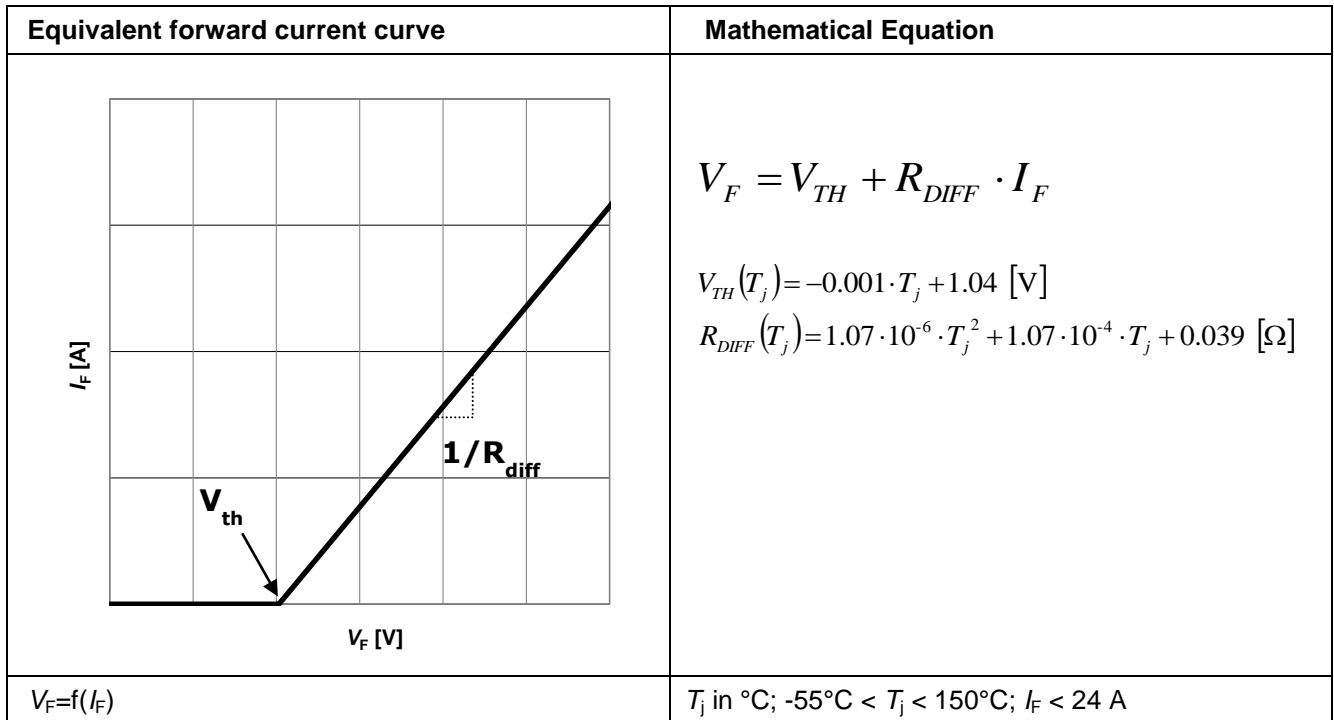


Table 11



## 6 Simplified Forward Characteristics Model

Table 12





7 Package outlines

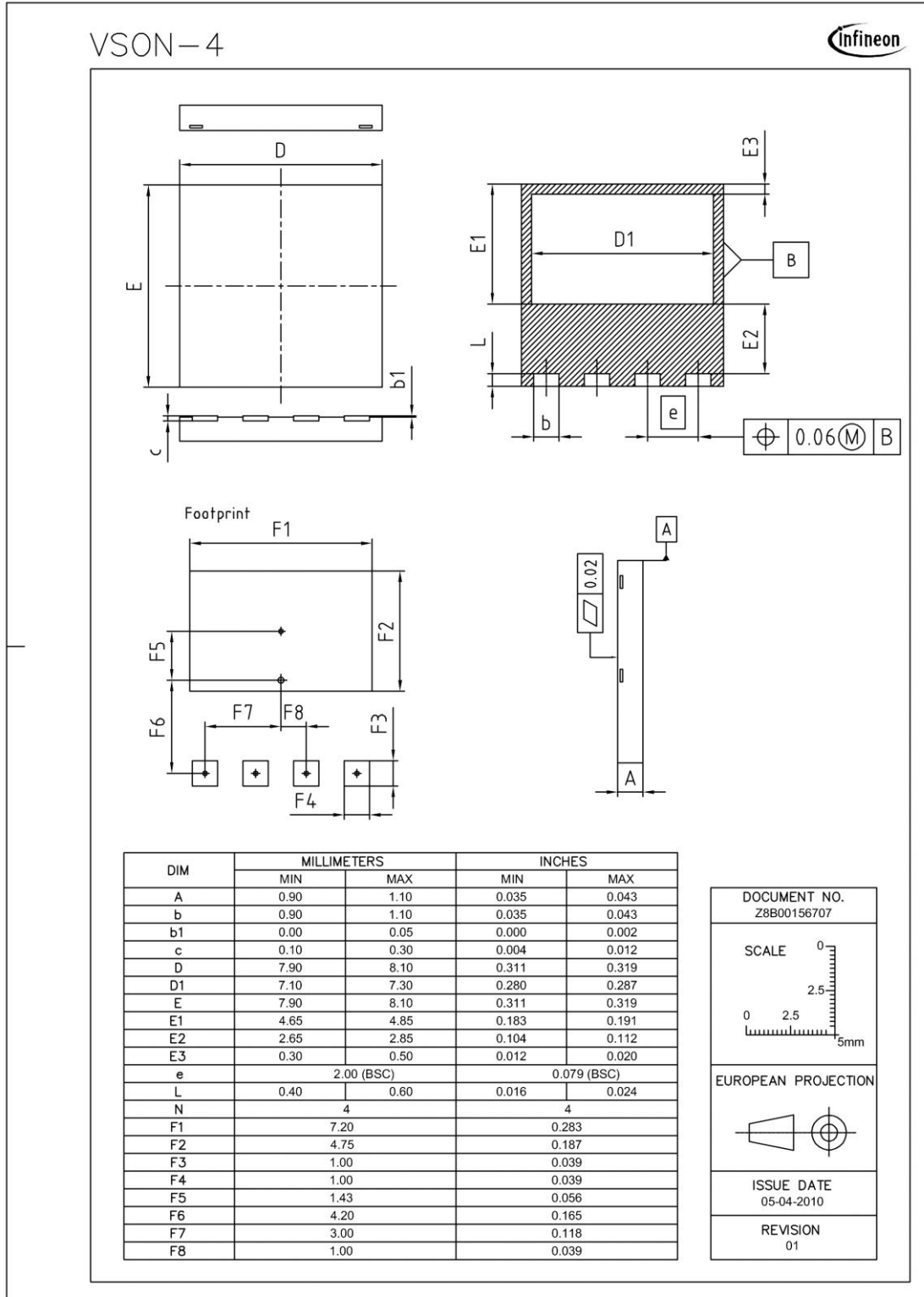


Figure 1 Outlines ThinPAK 8x8, dimensions in mm/inches

## 8 Revision History

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### 5<sup>th</sup> Generation thinQ!<sup>TM</sup> SiC Schottky Diode

Revision History: 2013-12-05, Rev. 2.0

**Previous Revision:**

| Revision | Subjects (major changes since last version) |
|----------|---|
| 2.0      | Release of the data sheet                   |
|          |   |

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